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# Advances in Fault Detection/Diagnosis of Electrical Power Devices

Guest Editors:

### Message from the Guest Editors

Dr. Hamed Habibi

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Dr. Amirmehdi Yazdani

Deadline for manuscript submissions:

closed (31 March 2023)

Reliability-oriented fault detection and fault-tolerant control are state-of-the-art research trends that demand further intensive research in order to obtain applicable cost-effective technology. This motivates the aim of this Special Issue of Electronics. Accordingly, I cordially invite researchers to contribute original and unique articles, as well as review papers. The topics of interest include (with emphasis on electrical power devices), but are not limited to:

- condition monitoring
- cyber-attack detection
- cyber-physical systems
- data-driven approaches including machine learning methods
- electrical power devices
- fault detection and diagnosis
- fault ride through
- fault-tolerant control
- incipient faults
- observer design
- signal-based approaches for features extraction









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# **Editor-in-Chief**

#### Prof. Dr. Flavio Canavero

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### Message from the Editor-in-Chief

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